

FDC645N

N-Channel PowerTrench® MOSFET

General Description

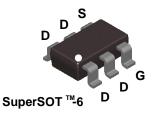
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low R_{DS(ON)} and fast switching speed.

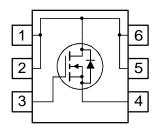
Applications

DC/DC converter

Features

- 5.5 A, 30 V. $R_{DS(ON)} = 30 \text{ m}\Omega$ @ $V_{GS} = 4.5 \text{ V}$ $R_{DS(ON)} = 26 \text{ m}\Omega$ @ $V_{GS} = 10 \text{ V}$
- High performance trench technology for extremely low $R_{\mbox{\scriptsize DS(ON)}}$
- Low gate charge (13 nC typical)
- · High power and current handling capability





Absolute Maximum Ratings T_A=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|------------------|------------------------------------|----------------|-------------|-------|
| V _{DSS} | Drain-Source Voltage | | 30 | V |
| V _{GSS} | Gate-Source Voltage | | ±12 | V |
| I _D | Drain Current - Continuous | (Note 1a) | 5.5 | А |
| | - Pulsed | | 20 | |
| P _D | Maximum Power Dissipation | (Note 1a) | 1.6 | W |
| | | (Note 1b) | 0.8 | |
| T_J, T_{STG} | Operating and Storage Junction Tem | perature Range | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 78 | °C/W |
|------------------|---|-----------|----|------|
| R _{θJC} | Thermal Resistance, Junction-to-Case | (Note 1) | 30 | °C/W |

Package Marking and Ordering Information

| | 9 | 9 | | |
|----------------|---------|-----------|------------|------------|
| Device Marking | Device | Reel Size | Tape width | Quantity |
| .645 | FDC645N | 7" | 8mm | 3000 units |

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|---|--|---|-----|----------------|----------------|-------|
| Off Char | acteristics | 1 | | l | l | I |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | 30 | | | V |
| <u>ΔBV_{DSS}</u> ΔT _J | Breakdown Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | | 22 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 24 \text{ V}, \ \ V_{GS} = 0 \text{ V}$ | | | 1 | μΑ |
| I _{GSSF} | Gate-Body Leakage, Forward | $V_{GS} = 12 \text{ V}, V_{DS} = 0 \text{ V}$ | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage, Reverse | $V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$ | | | -100 | nA |
| On Char | acteristics (Note 2) | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$ | 0.8 | 1.4 | 2 | V |
| $\Delta V_{GS(th)}$ ΔT_J | Gate Threshold Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | | - 4 | | mV/°C |
| R _{DS(on)} | Static Drain–Source On–Resistance | $V_{GS} = 4.5 \text{ V}, I_D = 5.5 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 6.2 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 5.5 \text{ A}, T_J = 125^{\circ}\text{C}$ | | 25 23 34 | 30 26 48 | mΩ |
| I _{D(on)} | On-State Drain Current | V _{GS} = 4.5 V, V _{DS} = 5 V | 20 | | | Α |
| g FS | Forward Transconductance | $V_{DS} = 10 \text{ V}, \qquad I_{D} = 5.5 \text{ A}$ | | 33 | | S |
| Dynamic | Characteristics | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ | | 1460 | | pF |
| Coss | Output Capacitance | f = 1.0 MHz | | 227 | | pF |
| Crss | Reverse Transfer Capacitance | 7 | | 96 | | pF |
| Switchir | g Characteristics (Note 2) | • | | | | |
| t _{d(on)} | Turn-On Delay Time | $V_{DS} = 15 \text{ V}, I_{D} = 1 \text{ A},$ | | 8 | 16 | ns |
| t _r | Turn-On Rise Time | $V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$ | | 9 | 18 | ns |
| t _{d(off)} | Turn-Off Delay Time | 7 | | 35 | 56 | ns |
| t _f | Turn-Off Fall Time | 1 | | 7 | 14 | ns |
| Qg | Total Gate Charge | $V_{DS} = 15 \text{ V}, I_{D} = 6.2 \text{ A},$ | | 13 | 21 | nC |
| Q _{gs} | Gate-Source Charge | V _{GS} = 4.5 V | | 3.6 | | nC |
| Q_{gd} | Gate-Drain Charge | 1 | | 3.6 | | nC |
| Drain-S | ource Diode Characteristics | and Maximum Ratings | • | • | • | |
| ls | Maximum Continuous Drain-Source | | | | 1.3 | Α |
| V _{SD} | Drain–Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_{S} = 1.3 \text{ A}$ (Note 2) | | 0.7 | 1.2 | V |

Notes:

- R_{0JA} is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.
 - a. 78°C/W when mounted on a 1in^2 pad of 2oz copper on FR-4 board.
 - b. 156°C/W when mounted on a minimum pad.
- 2. Pulse Test: Pulse Width $\leq 300~\mu\text{s},~\text{Duty Cycle} \leq 2.0\%$

Typical Characteristics

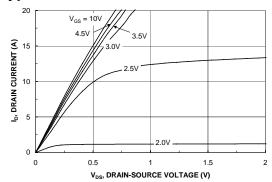
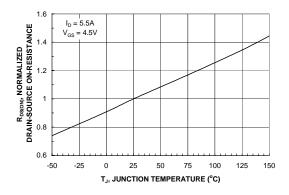


Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



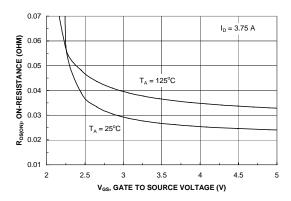
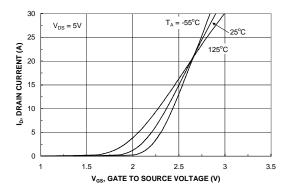


Figure 3. On-Resistance Variation withTemperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



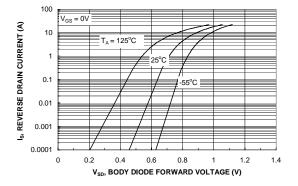
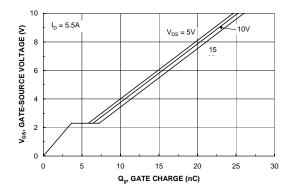


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



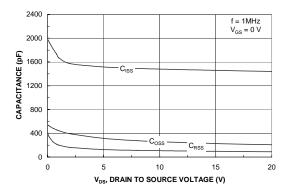
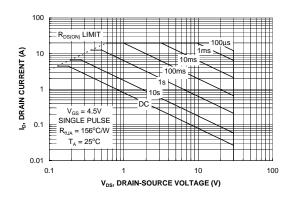


Figure 7. Gate Charge Characteristics.





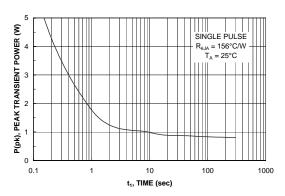


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

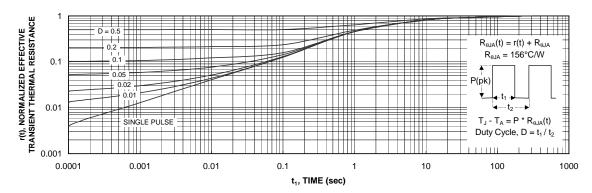


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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